

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10599546	BAE ET AL.
	Examiner	Art Unit
	Chen, Catheryne	1655

SEARCHED

Class	Subclass	Date	Examiner
none	none	11/05/07	CC

SEARCH NOTES

Search Notes	Date	Examiner
INVENTOR NAME, USPT, JPAB, EPAB, DWPI, MEDLINE, EMBASE, BIOSIS, CAPLUS, REGISTRY	11/05/07	CC
updated search	4/21/08	CC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner